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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Obsolete
Number of LABs/CLBs	2880
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	81
Number of Gates	48000
Voltage - Supply	2.25V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	100-LQFP
Supplier Device Package	100-TQFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/a54sx32a-1tq100">https://www.e-xfl.com/product-detail/microchip-technology/a54sx32a-1tq100</a>

## Other Architectural Features

### Technology

The Actel SX-A family is implemented on a high-voltage, twin-well CMOS process using  $0.22\ \mu\text{m}$  /  $0.25\ \mu\text{m}$  design rules. The metal-to-metal antifuse is comprised of a combination of amorphous silicon and dielectric material with barrier metals and has a programmed ('on' state) resistance of  $25\ \Omega$  with capacitance of  $1.0\ \text{fF}$  for low signal impedance.

### Performance

The unique architectural features of the SX-A family enable the devices to operate with internal clock frequencies of 350 MHz, causing very fast execution of even complex logic functions. The SX-A family is an optimal platform upon which to integrate the functionality previously contained in multiple complex programmable logic devices (CPLDs). In addition, designs that previously would have required a gate array to meet performance goals can be integrated into an SX-A device with dramatic improvements in cost and time-to-market. Using timing-driven place-and-route tools, designers can achieve highly deterministic device performance.

### User Security

Reverse engineering is virtually impossible in SX-A devices because it is extremely difficult to distinguish between programmed and unprogrammed antifuses. In addition, since SX-A is a nonvolatile, single-chip solution, there is no configuration bitstream to intercept at device power-up.

The Actel FuseLock advantage ensures that unauthorized users will not be able to read back the contents of an Actel antifuse FPGA. In addition to the inherent strengths of the architecture, special security fuses that prevent internal probing and overwriting are hidden throughout the fabric of the device. They are located where they cannot be accessed or bypassed without destroying access to the rest of the device, making both invasive and more-subtle noninvasive attacks ineffective against Actel antifuse FPGAs.

Look for this symbol to ensure your valuable IP is secure (Figure 1-11).



Figure 1-11 • FuseLock

For more information, refer to Actel's *Implementation of Security in Actel Antifuse FPGAs* application note.

## I/O Modules

For a simplified I/O schematic, refer to Figure 1 in the application note, *Actel eX, SX-A, and RTSX-S I/Os*.

Each user I/O on an SX-A device can be configured as an input, an output, a tristate output, or a bidirectional pin. Mixed I/O standards can be set for individual pins, though this is only allowed with the same voltage as the input. These I/Os, combined with array registers, can achieve clock-to-output-pad timing as fast as 3.8 ns, even without the dedicated I/O registers. In most FPGAs, I/O cells that have embedded latches and flip-flops, requiring instantiation in HDL code; this is a design complication not encountered in SX-A FPGAs. Fast pin-to-pin timing ensures that the device is able to interface with any other device in the system, which in turn enables parallel design of system components and reduces overall design time. All unused I/Os are configured as tristate outputs by the Actel Designer software, for maximum flexibility when designing new boards or migrating existing designs.

SX-A I/Os should be driven by high-speed push-pull devices with a low-resistance pull-up device when being configured as tristate output buffers. If the I/O is driven by a voltage level greater than  $V_{CC1}$  and a fast push-pull device is NOT used, the high-resistance pull-up of the driver and the internal circuitry of the SX-A I/O may create a voltage divider. This voltage divider could pull the input voltage below specification for some devices connected to the driver. A logic '1' may not be correctly presented in this case. For example, if an open drain driver is used with a pull-up resistor to 5 V to provide the logic '1' input, and  $V_{CC1}$  is set to 3.3 V on the SX-A device, the input signal may be pulled down by the SX-A input.

Each I/O module has an available power-up resistor of approximately  $50\ \text{k}\Omega$  that can configure the I/O in a known state during power-up. For nominal pull-up and pull-down resistor values, refer to Table 1-4 on page 1-8 of the application note *Actel eX, SX-A, and RTSX-S I/Os*. Just slightly before  $V_{CCA}$  reaches 2.5 V, the resistors are disabled, so the I/Os will be controlled by user logic. See Table 1-2 on page 1-8 and Table 1-3 on page 1-8 for more information concerning available I/O features.

**Table 2-8 • AC Specifications (5 V PCI Operation)**

Symbol	Parameter	Condition	Min.	Max.	Units
$I_{OH(AC)}$	Switching Current High	$0 < V_{OUT} \leq 1.4$ <sup>1</sup>	-44	–	mA
		$1.4 \leq V_{OUT} < 2.4$ <sup>1, 2</sup>	$(-44 + (V_{OUT} - 1.4)/0.024)$	–	mA
		$3.1 < V_{OUT} < V_{CCI}$ <sup>1, 3</sup>	–	EQ 2-1 on page 2-5	–
	(Test Point)	$V_{OUT} = 3.1$ <sup>3</sup>	–	-142	mA
$I_{OL(AC)}$	Switching Current Low	$V_{OUT} \geq 2.2$ <sup>1</sup>	95	–	mA
		$2.2 > V_{OUT} > 0.55$ <sup>1</sup>	$(V_{OUT}/0.023)$	–	mA
		$0.71 > V_{OUT} > 0$ <sup>1, 3</sup>	–	EQ 2-2 on page 2-5	–
	(Test Point)	$V_{OUT} = 0.71$ <sup>3</sup>	–	206	mA
$I_{CL}$	Low Clamp Current	$-5 < V_{IN} \leq -1$	$-25 + (V_{IN} + 1)/0.015$	–	mA
$slew_R$	Output Rise Slew Rate	0.4 V to 2.4 V load <sup>4</sup>	1	5	V/ns
$slew_F$	Output Fall Slew Rate	2.4 V to 0.4 V load <sup>4</sup>	1	5	V/ns

**Notes:**

1. Refer to the *V<sub>I</sub>* curves in Figure 2-1 on page 2-5. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half size output drivers may be used on these signals. This specification does not apply to CLK and RST#, which are system outputs. "Switching Current High" specifications are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD#, which are open drain outputs.
2. Note that this segment of the minimum current curve is drawn from the AC drive point directly to the DC drive point rather than toward the voltage rail (as is done in the pull-down curve). This difference is intended to allow for an optional N-channel pull-up.
3. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (A and B) are provided with the respective diagrams in Figure 2-1 on page 2-5. The equation defined maximum should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.
4. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per revision 2.0 of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is now required (the maximum is no longer simply a guideline). Since adherence to the maximum slew rate was not required prior to revision 2.1 of the specification, there may be components in the market for some time that have faster edge rates; therefore, motherboard designers must bear in mind that rise and fall times faster than this specification could occur and should ensure that signal integrity modeling accounts for this. Rise slew rate does not apply to open drain outputs.

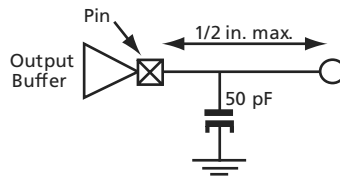


Figure 2-2 shows the 3.3 V PCI V/I curve and the minimum and maximum PCI drive characteristics of the SX-A family.

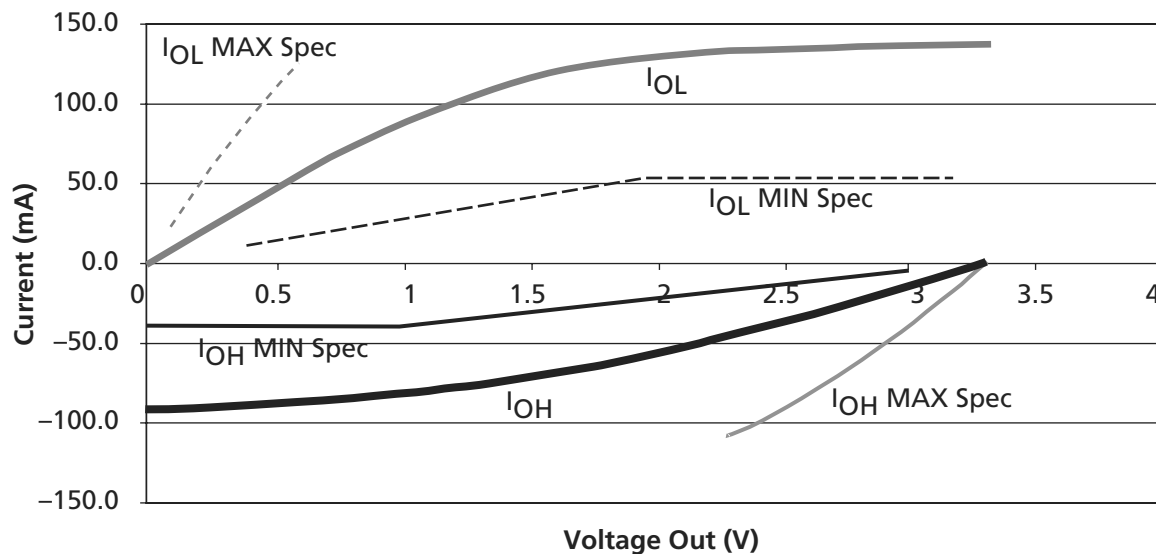


Figure 2-2 • **3.3 V PCI V/I Curve for SX-A Family**

$$I_{OH} = (98.0/V_{CCI}) * (V_{OUT} - V_{CCI}) * (V_{OUT} + 0.4V_{CCI})$$

for  $0.7 V_{CCI} < V_{OUT} < V_{CCI}$

EQ 2-3

$$I_{OL} = (256/V_{CCI}) * V_{OUT} * (V_{CCI} - V_{OUT})$$

for  $0V < V_{OUT} < 0.18 V_{CCI}$

EQ 2-4

To determine the heat sink's thermal performance, use the following equation:

$$\theta_{JA(TOTAL)} = \theta_{JC} + \theta_{CS} + \theta_{SA}$$

EQ 2-14

where:

$$\theta_{CS} = 0.37^{\circ}\text{C/W}$$

= thermal resistance of the interface material between the case and the heat sink, usually provided by the thermal interface manufacturer

$$\theta_{SA} = \text{thermal resistance of the heat sink in } ^{\circ}\text{C/W}$$

$$\theta_{SA} = \theta_{JA(TOTAL)} - \theta_{JC} - \theta_{CS}$$

EQ 2-15

$$\theta_{SA} = 13.33^{\circ}\text{C/W} - 3.20^{\circ}\text{C/W} - 0.37^{\circ}\text{C/W}$$

$$\theta_{SA} = 9.76^{\circ}\text{C/W}$$

A heat sink with a thermal resistance of  $9.76^{\circ}\text{C/W}$  or better should be used. Thermal resistance of heat sinks is a function of airflow. The heat sink performance can be significantly improved with the presence of airflow.

Carefully estimating thermal resistance is important in the long-term reliability of an Actel FPGA. Design engineers should always correlate the power consumption of the device with the maximum allowable power dissipation of the package selected for that device, using the provided thermal resistance data.

Note: The values may vary depending on the application.

## Timing Characteristics

Timing characteristics for SX-A devices fall into three categories: family-dependent, device-dependent, and design-dependent. The input and output buffer characteristics are common to all SX-A family members. Internal routing delays are device-dependent. Design dependency means actual delays are not determined until after placement and routing of the user's design are complete. The timing characteristics listed in this datasheet represent sample timing numbers of the SX-A devices. Design-specific delay values may be determined by using Timer or performing simulation after successful place-and-route with the Designer software.

### Critical Nets and Typical Nets

Propagation delays are expressed only for typical nets, which are used for initial design performance evaluation. Critical net delays can then be applied to the most timing-critical paths. Critical nets are determined by net property assignment prior to placement and routing. Up to 6 percent of the nets in a design may be designated as critical, while 90 percent of the nets in a design are typical.

## Long Tracks

Some nets in the design use long tracks. Long tracks are special routing resources that span multiple rows, columns, or modules. Long tracks employ three to five antifuse connections. This increases capacitance and resistance, resulting in longer net delays for macros connected to long tracks. Typically, up to 6 percent of nets in a fully utilized device require long tracks. Long tracks contribute approximately 4 ns to 8.4 ns delay. This additional delay is represented statistically in higher fanout routing delays.

## Timing Derating

SX-A devices are manufactured with a CMOS process. Therefore, device performance varies according to temperature, voltage, and process changes. Minimum timing parameters reflect maximum operating voltage, minimum operating temperature, and best-case processing. Maximum timing parameters reflect minimum operating voltage, maximum operating temperature, and worst-case processing.

## Temperature and Voltage Derating Factors

Table 2-13 • Temperature and Voltage Derating Factors  
(Normalized to Worst-Case Commercial,  $T_J = 70^\circ\text{C}$ ,  $V_{CCA} = 2.25\text{ V}$ )

<b>V<sub>CCA</sub></b>	<b>Junction Temperature (T<sub>J</sub>)</b>						
	<b>–55°C</b>	<b>–40°C</b>	<b>0°C</b>	<b>25°C</b>	<b>70°C</b>	<b>85°C</b>	<b>125°C</b>
2.250 V	0.79	0.80	0.87	0.89	1.00	1.04	1.14
2.500 V	0.74	0.75	0.82	0.83	0.94	0.97	1.07
2.750 V	0.68	0.69	0.75	0.77	0.87	0.90	0.99

Table 2-15 • **A54SX08A Timing Characteristics**  
(Worst-Case Commercial Conditions  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 2.25\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	-2 Speed		-1 Speed		Std. Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Dedicated (Hardwired) Array Clock Networks										
t <sub>HCKH</sub>	Input Low to High (Pad to R-cell Input)		1.4		1.6		1.8		2.6	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.3		1.5		1.7		2.4	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.6		1.8		2.1		2.9		ns
t <sub>HPWL</sub>	Minimum Pulse Width Low	1.6		1.8		2.1		2.9		ns
t <sub>HCKSW</sub>	Maximum Skew		0.4		0.4		0.5		0.7	ns
t <sub>HP</sub>	Minimum Period	3.2		3.6		4.2		5.8		ns
f <sub>HMAX</sub>	Maximum Frequency		313		278		238		172	MHz
Routed Array Clock Networks										
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		1.0		1.1		1.3		1.8	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		1.0		1.1		1.3		1.8	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		1.1		1.2		1.4		2.0	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.4	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.6		1.8		2.1		2.9		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.6		1.8		2.1		2.9		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		0.7		0.8		0.9		1.3	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		0.7		0.8		0.9		1.3	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		0.9		1.0		1.2		1.7	ns

Table 2-18 • A54SX08A Timing Characteristics

(Worst-Case Commercial Conditions  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 2.3\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	–2 Speed		–1 Speed		Std. Speed		–F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
2.5 V LVCMOS Output Module Timing <sup>1,2</sup>										
t <sub>DLH</sub>	Data-to-Pad Low to High		3.9		4.4		5.2		7.2	ns
t <sub>DHL</sub>	Data-to-Pad High to Low		3.0		3.4		3.9		5.5	ns
t <sub>DHLS</sub>	Data-to-Pad High to Low—low slew		13.3		15.1		17.7		24.8	ns
t <sub>ENZL</sub>	Enable-to-Pad, Z to L		2.8		3.2		3.7		5.2	ns
t <sub>ENZLS</sub>	Data-to-Pad, Z to L—low slew		13.7		15.5		18.2		25.5	ns
t <sub>ENZH</sub>	Enable-to-Pad, Z to H		3.9		4.4		5.2		7.2	ns
t <sub>ENLZ</sub>	Enable-to-Pad, L to Z		2.5		2.8		3.3		4.7	ns
t <sub>ENHZ</sub>	Enable-to-Pad, H to Z		3.0		3.4		3.9		5.5	ns
d <sub>TLH</sub> <sup>3</sup>	Delta Low to High		0.037		0.043		0.051		0.071	ns/pF
d <sub>THL</sub> <sup>3</sup>	Delta High to Low		0.017		0.023		0.023		0.037	ns/pF
d <sub>THLS</sub> <sup>3</sup>	Delta High to Low—low slew		0.06		0.071		0.086		0.117	ns/pF

**Note:**

- Delays based on 35 pF loading.
- The equivalent I/O Attribute Editor settings for 2.5 V LVCMOS is 2.5 V LVTTTL in the software.
- To obtain the slew rate, substitute the appropriate Delta value, load capacitance, and the  $V_{CCI}$  value into the following equation:  

$$\text{Slew Rate [V/ns]} = (0.1 * V_{CCI} - 0.9 * V_{CCI}) / (C_{load} * d_{T[HL|HL|HLS]})$$
where  $C_{load}$  is the load capacitance driven by the I/O in pF  
 $d_{T[HL|HL|HLS]}$  is the worst case delta value from the datasheet in ns/pF.



Table 2-21 • A54SX16A Timing Characteristics (Continued)  
(Worst-Case Commercial Conditions,  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 3.0\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	-3 Speed <sup>1</sup>		-2 Speed		-1 Speed		Std. Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
$t_{INYH}$	Input Data Pad to Y High 5 V PCI		0.5		0.5		0.6		0.7		0.9	ns
$t_{INYL}$	Input Data Pad to Y Low 5 V PCI		0.7		0.8		0.9		1.1		1.5	ns
$t_{INYH}$	Input Data Pad to Y High 5 V TTL		0.5		0.5		0.6		0.7		0.9	ns
$t_{INYL}$	Input Data Pad to Y Low 5 V TTL		0.7		0.8		0.9		1.1		1.5	ns
<b>Input Module Predicted Routing Delays<sup>2</sup></b>												
$t_{IRD1}$	FO = 1 Routing Delay		0.3		0.3		0.3		0.4		0.6	ns
$t_{IRD2}$	FO = 2 Routing Delay		0.4		0.5		0.5		0.6		0.8	ns
$t_{IRD3}$	FO = 3 Routing Delay		0.5		0.6		0.7		0.8		1.1	ns
$t_{IRD4}$	FO = 4 Routing Delay		0.7		0.8		0.9		1.0		1.4	ns
$t_{IRD8}$	FO = 8 Routing Delay		1.2		1.4		1.5		0.8		2.5	ns
$t_{IRD12}$	FO = 12 Routing Delay		1.7		2.0		2.2		2.6		3.6	ns

**Notes:**

1. All -3 speed grades have been discontinued.
2. For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
3. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.

Table 2-24 • **A54SX16A Timing Characteristics**  
**(Worst-Case Commercial Conditions  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 4.75\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )**

Parameter	Description	–3 Speed*		–2 Speed		–1 Speed		Std. Speed		–F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Dedicated (Hardwired) Array Clock Networks												
t <sub>HCKH</sub>	Input Low to High (Pad to R-cell Input)		1.2		1.4		1.6		1.8		2.8	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.0		1.1		1.2		1.5		2.2	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.4		1.7		1.9		2.2		3.0		ns
t <sub>HPWL</sub>	Minimum Pulse Width Low	1.4		1.7		1.9		2.2		3.0		ns
t <sub>HCKSW</sub>	Maximum Skew		0.3		0.3		0.4		0.4		0.7	ns
t <sub>HP</sub>	Minimum Period	2.8		3.4		3.8		4.4		6.0		ns
f <sub>HMAX</sub>	Maximum Frequency		357		294		263		227		167	MHz
Routed Array Clock Networks												
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		1.0		1.2		1.3		1.6		2.2	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		1.1		1.3		1.5		1.7		2.4	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		1.1		1.3		1.5		1.7		2.4	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		1.1		1.3		1.5		1.7		2.4	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.0		2.8	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		1.3		1.5		1.7		2.0		2.8	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.4		1.7		1.9		2.2		3.0		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.4		1.7		1.9		2.2		3.0		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		0.8		0.9		1.0		1.2		1.7	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		0.8		0.9		1.0		1.2		1.7	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		1.0		1.1		1.3		1.5		2.1	ns

**Note:** \*All –3 speed grades have been discontinued.

Table 2-37 • **A54SX72A Timing Characteristics**  
(Worst-Case Commercial Conditions  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 3.0\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )

Parameter	Description	–3 Speed*		–2 Speed		–1 Speed		Std. Speed		–F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Dedicated (Hardwired) Array Clock Networks												
t <sub>HCKH</sub>	Input Low to High (Pad to R-cell Input)		1.6		1.9		2.1		2.5		3.8	ns
t <sub>HCKL</sub>	Input High to Low (Pad to R-cell Input)		1.7		1.9		2.1		2.5		3.8	ns
t <sub>HPWH</sub>	Minimum Pulse Width High	1.5		1.7		2.0		2.3		3.2		ns
t <sub>HPWL</sub>	Minimum Pulse Width Low	1.5		1.7		2.0		2.3		3.2		ns
t <sub>HCKSW</sub>	Maximum Skew		1.4		1.6		1.8		2.1		3.3	ns
t <sub>HP</sub>	Minimum Period	3.0		3.4		4.0		4.6		6.4		ns
f <sub>HMAX</sub>	Maximum Frequency		333		294		250		217		156	MHz
Routed Array Clock Networks												
t <sub>RCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		2.2		2.6		2.9		3.4		4.8	ns
t <sub>RCKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		2.8		3.3		3.7		4.3		6.0	ns
t <sub>RCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		2.4		2.8		3.2		3.7		5.2	ns
t <sub>RCKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		2.9		3.4		3.8		4.5		6.2	ns
t <sub>RCKH</sub>	Input Low to High (100% Load) (Pad to R-cell Input)		2.6		3.0		3.4		4.0		5.6	ns
t <sub>RCKL</sub>	Input High to Low (100% Load) (Pad to R-cell Input)		3.1		3.6		4.1		4.8		6.7	ns
t <sub>RPWH</sub>	Minimum Pulse Width High	1.5		1.7		2.0		2.3		3.2		ns
t <sub>RPWL</sub>	Minimum Pulse Width Low	1.5		1.7		2.0		2.3		3.2		ns
t <sub>RCKSW</sub>	Maximum Skew (Light Load)		1.9		2.2		2.5		3		4.1	ns
t <sub>RCKSW</sub>	Maximum Skew (50% Load)		1.9		2.1		2.4		2.8		3.9	ns
t <sub>RCKSW</sub>	Maximum Skew (100% Load)		1.9		2.1		2.4		2.8		3.9	ns
Quadrant Array Clock Networks												
t <sub>QCKH</sub>	Input Low to High (Light Load) (Pad to R-cell Input)		1.3		1.5		1.7		1.9		2.7	ns
t <sub>QCHKL</sub>	Input High to Low (Light Load) (Pad to R-cell Input)		1.3		1.5		1.7		2		2.8	ns
t <sub>QCKH</sub>	Input Low to High (50% Load) (Pad to R-cell Input)		1.5		1.7		1.9		2.2		3.1	ns
t <sub>QCHKL</sub>	Input High to Low (50% Load) (Pad to R-cell Input)		1.5		1.8		2		2.3		3.2	ns

**Note:** \*All –3 speed grades have been discontinued.

Table 2-41 • **A54SX72A Timing Characteristics**  
**(Worst-Case Commercial Conditions  $V_{CCA} = 2.25\text{ V}$ ,  $V_{CCI} = 4.75\text{ V}$ ,  $T_J = 70^\circ\text{C}$ )**

Parameter	Description	–3 Speed <sup>1</sup>		–2 Speed		–1 Speed		Std. Speed		–F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
5 V PCI Output Module Timing <sup>2</sup>												
t <sub>DLH</sub>	Data-to-Pad Low to High	2.7		3.1		3.5		4.1		5.7		ns
t <sub>DHL</sub>	Data-to-Pad High to Low	3.4		3.9		4.4		5.1		7.2		ns
t <sub>ENZL</sub>	Enable-to-Pad, Z to L	1.3		1.5		1.7		2.0		2.8		ns
t <sub>ENZH</sub>	Enable-to-Pad, Z to H	2.7		3.1		3.5		4.1		5.7		ns
t <sub>ENLZ</sub>	Enable-to-Pad, L to Z	3.0		3.5		3.9		4.6		6.4		ns
t <sub>ENHZ</sub>	Enable-to-Pad, H to Z	3.4		3.9		4.4		5.1		7.2		ns
d <sub>TLH</sub> <sup>3</sup>	Delta Low to High	0.016		0.016		0.02		0.022		0.032		ns/pF
d <sub>THL</sub> <sup>3</sup>	Delta High to Low	0.026		0.03		0.032		0.04		0.052		ns/pF
5 V TTL Output Module Timing <sup>4</sup>												
t <sub>DLH</sub>	Data-to-Pad Low to High	2.4		2.8		3.1		3.7		5.1		ns
t <sub>DHL</sub>	Data-to-Pad High to Low	3.1		3.5		4.0		4.7		6.6		ns
t <sub>DHLS</sub>	Data-to-Pad High to Low—low slew	7.4		8.5		9.7		11.4		15.9		ns
t <sub>ENZL</sub>	Enable-to-Pad, Z to L	2.1		2.4		2.7		3.2		4.5		ns
t <sub>ENZLS</sub>	Enable-to-Pad, Z to L—low slew	7.4		8.4		9.5		11.0		15.4		ns
t <sub>ENZH</sub>	Enable-to-Pad, Z to H	2.4		2.8		3.1		3.7		5.1		ns
t <sub>ENLZ</sub>	Enable-to-Pad, L to Z	3.6		4.2		4.7		5.6		7.8		ns
t <sub>ENHZ</sub>	Enable-to-Pad, H to Z	3.1		3.5		4.0		4.7		6.6		ns
d <sub>TLH</sub> <sup>3</sup>	Delta Low to High	0.014		0.017		0.017		0.023		0.031		ns/pF
d <sub>THL</sub> <sup>3</sup>	Delta High to Low	0.023		0.029		0.031		0.037		0.051		ns/pF
d <sub>THLS</sub> <sup>3</sup>	Delta High to Low—low slew	0.043		0.046		0.057		0.066		0.089		ns/pF

**Notes:**

1. All –3 speed grades have been discontinued.
2. Delays based on 50 pF loading.
3. To obtain the slew rate, substitute the appropriate Delta value, load capacitance, and the  $V_{CCI}$  value into the following equation:  

$$\text{Slew Rate [V/ns]} = (0.1 * V_{CCI} - 0.9 * V_{CCI}) / (C_{load} * d_{T[HL|HL|HLS]})$$
 where  $C_{load}$  is the load capacitance driven by the I/O in pF  
 $d_{T[HL|HL|HLS]}$  is the worst case delta value from the datasheet in ns/pF.
4. Delays based on 35 pF loading.

# Package Pin Assignments

## 208-Pin PQFP

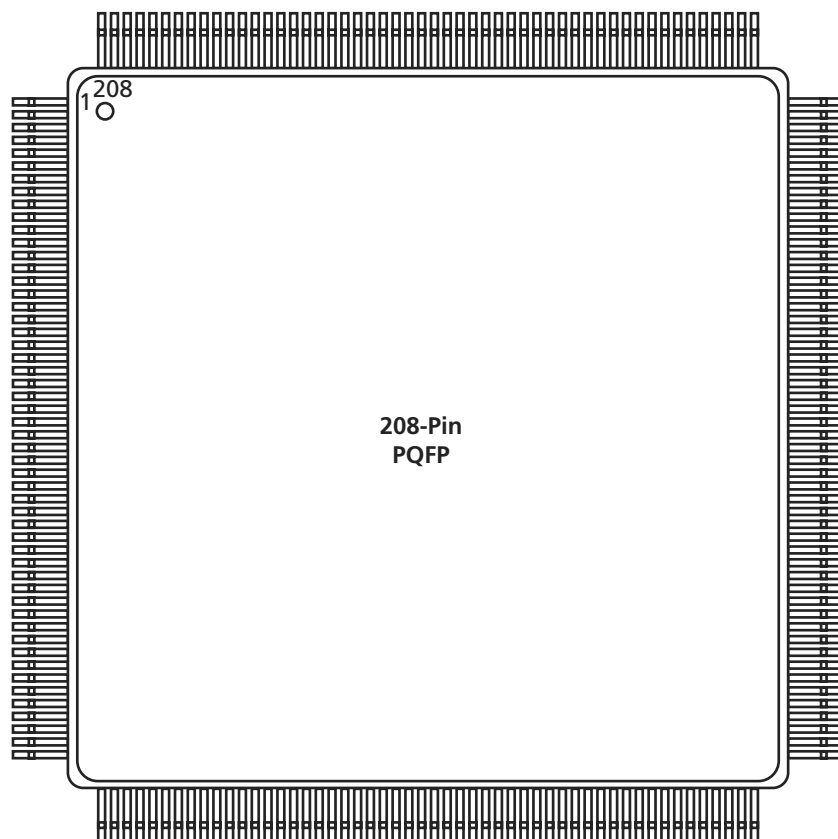


Figure 3-1 • 208-Pin PQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

208-Pin PQFP				
Pin Number	A54SX08A Function	A54SX16A Function	A54SX32A Function	A54SX72A Function
1	GND	GND	GND	GND
2	TDI, I/O	TDI, I/O	TDI, I/O	TDI, I/O
3	I/O	I/O	I/O	I/O
4	NC	I/O	I/O	I/O
5	I/O	I/O	I/O	I/O
6	NC	I/O	I/O	I/O
7	I/O	I/O	I/O	I/O
8	I/O	I/O	I/O	I/O
9	I/O	I/O	I/O	I/O
10	I/O	I/O	I/O	I/O
11	TMS	TMS	TMS	TMS
12	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
13	I/O	I/O	I/O	I/O
14	NC	I/O	I/O	I/O
15	I/O	I/O	I/O	I/O
16	I/O	I/O	I/O	I/O
17	NC	I/O	I/O	I/O
18	I/O	I/O	I/O	GND
19	I/O	I/O	I/O	V <sub>CCA</sub>
20	NC	I/O	I/O	I/O
21	I/O	I/O	I/O	I/O
22	I/O	I/O	I/O	I/O
23	NC	I/O	I/O	I/O
24	I/O	I/O	I/O	I/O
25	NC	NC	NC	I/O
26	GND	GND	GND	GND
27	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
28	GND	GND	GND	GND
29	I/O	I/O	I/O	I/O
30	TRST, I/O	TRST, I/O	TRST, I/O	TRST, I/O
31	NC	I/O	I/O	I/O
32	I/O	I/O	I/O	I/O
33	I/O	I/O	I/O	I/O
34	I/O	I/O	I/O	I/O
35	NC	I/O	I/O	I/O

208-Pin PQFP				
Pin Number	A54SX08A Function	A54SX16A Function	A54SX32A Function	A54SX72A Function
36	I/O	I/O	I/O	I/O
37	I/O	I/O	I/O	I/O
38	I/O	I/O	I/O	I/O
39	NC	I/O	I/O	I/O
40	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
41	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
42	I/O	I/O	I/O	I/O
43	I/O	I/O	I/O	I/O
44	I/O	I/O	I/O	I/O
45	I/O	I/O	I/O	I/O
46	I/O	I/O	I/O	I/O
47	I/O	I/O	I/O	I/O
48	NC	I/O	I/O	I/O
49	I/O	I/O	I/O	I/O
50	NC	I/O	I/O	I/O
51	I/O	I/O	I/O	I/O
52	GND	GND	GND	GND
53	I/O	I/O	I/O	I/O
54	I/O	I/O	I/O	I/O
55	I/O	I/O	I/O	I/O
56	I/O	I/O	I/O	I/O
57	I/O	I/O	I/O	I/O
58	I/O	I/O	I/O	I/O
59	I/O	I/O	I/O	I/O
60	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
61	NC	I/O	I/O	I/O
62	I/O	I/O	I/O	I/O
63	I/O	I/O	I/O	I/O
64	NC	I/O	I/O	I/O
65	I/O	I/O	NC	I/O
66	I/O	I/O	I/O	I/O
67	NC	I/O	I/O	I/O
68	I/O	I/O	I/O	I/O
69	I/O	I/O	I/O	I/O
70	NC	I/O	I/O	I/O

329-Pin PBGA	
Pin Number	A54SX32A Function
A1	GND
A2	GND
A3	V <sub>CCI</sub>
A4	NC
A5	I/O
A6	I/O
A7	V <sub>CCI</sub>
A8	NC
A9	I/O
A10	I/O
A11	I/O
A12	I/O
A13	CLKB
A14	I/O
A15	I/O
A16	I/O
A17	I/O
A18	I/O
A19	I/O
A20	I/O
A21	NC
A22	V <sub>CCI</sub>
A23	GND
AA1	V <sub>CCI</sub>
AA2	I/O
AA3	GND
AA4	I/O
AA5	I/O
AA6	I/O
AA7	I/O
AA8	I/O
AA9	I/O
AA10	I/O
AA11	I/O
AA12	I/O
AA13	I/O
AA14	I/O

329-Pin PBGA	
Pin Number	A54SX32A Function
AA15	I/O
AA16	I/O
AA17	I/O
AA18	I/O
AA19	I/O
AA20	TDO, I/O
AA21	V <sub>CCI</sub>
AA22	I/O
AA23	V <sub>CCI</sub>
AB1	I/O
AB2	GND
AB3	I/O
AB4	I/O
AB5	I/O
AB6	I/O
AB7	I/O
AB8	I/O
AB9	I/O
AB10	I/O
AB11	PRB, I/O
AB12	I/O
AB13	HCLK
AB14	I/O
AB15	I/O
AB16	I/O
AB17	I/O
AB18	I/O
AB19	I/O
AB20	I/O
AB21	I/O
AB22	GND
AB23	I/O
AC1	GND
AC2	V <sub>CCI</sub>
AC3	NC
AC4	I/O
AC5	I/O

329-Pin PBGA	
Pin Number	A54SX32A Function
AC6	I/O
AC7	I/O
AC8	I/O
AC9	V <sub>CCI</sub>
AC10	I/O
AC11	I/O
AC12	I/O
AC13	I/O
AC14	I/O
AC15	NC
AC16	I/O
AC17	I/O
AC18	I/O
AC19	I/O
AC20	I/O
AC21	NC
AC22	V <sub>CCI</sub>
AC23	GND
B1	V <sub>CCI</sub>
B2	GND
B3	I/O
B4	I/O
B5	I/O
B6	I/O
B7	I/O
B8	I/O
B9	I/O
B10	I/O
B11	I/O
B12	PRA, I/O
B13	CLKA
B14	I/O
B15	I/O
B16	I/O
B17	I/O
B18	I/O
B19	I/O

329-Pin PBGA	
Pin Number	A54SX32A Function
B20	I/O
B21	I/O
B22	GND
B23	V <sub>CCI</sub>
C1	NC
C2	TDI, I/O
C3	GND
C4	I/O
C5	I/O
C6	I/O
C7	I/O
C8	I/O
C9	I/O
C10	I/O
C11	I/O
C12	I/O
C13	I/O
C14	I/O
C15	I/O
C16	I/O
C17	I/O
C18	I/O
C19	I/O
C20	I/O
C21	V <sub>CCI</sub>
C22	GND
C23	NC
D1	I/O
D2	I/O
D3	I/O
D4	TCK, I/O
D5	I/O
D6	I/O
D7	I/O
D8	I/O
D9	I/O
D10	I/O

# 144-Pin FBGA

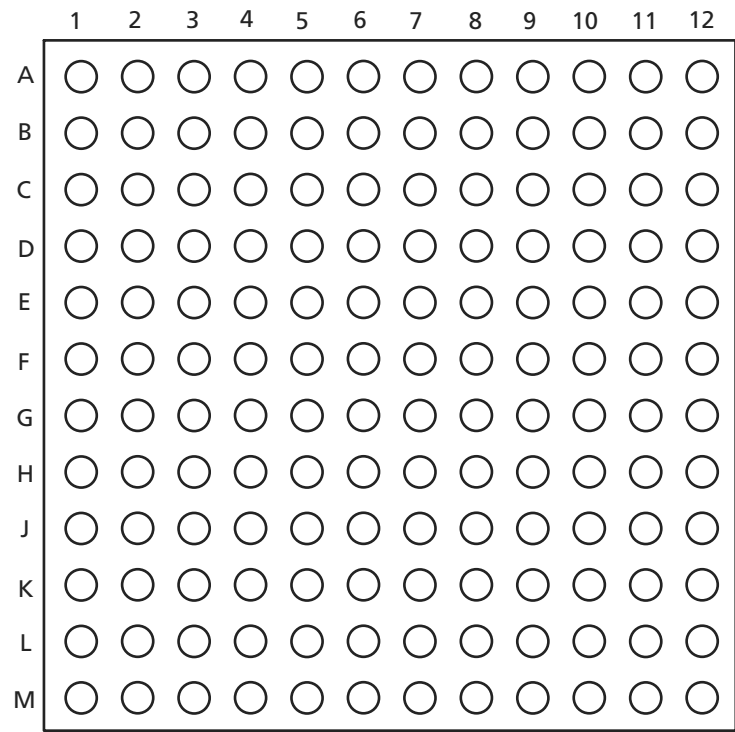


Figure 3-6 • 144-Pin FBGA (Top View)

**Note**

For Package Manufacturing and Environmental information, visit Resource center at <http://www.actel.com/products/rescenter/package/index.html>.



## 256-Pin FBGA

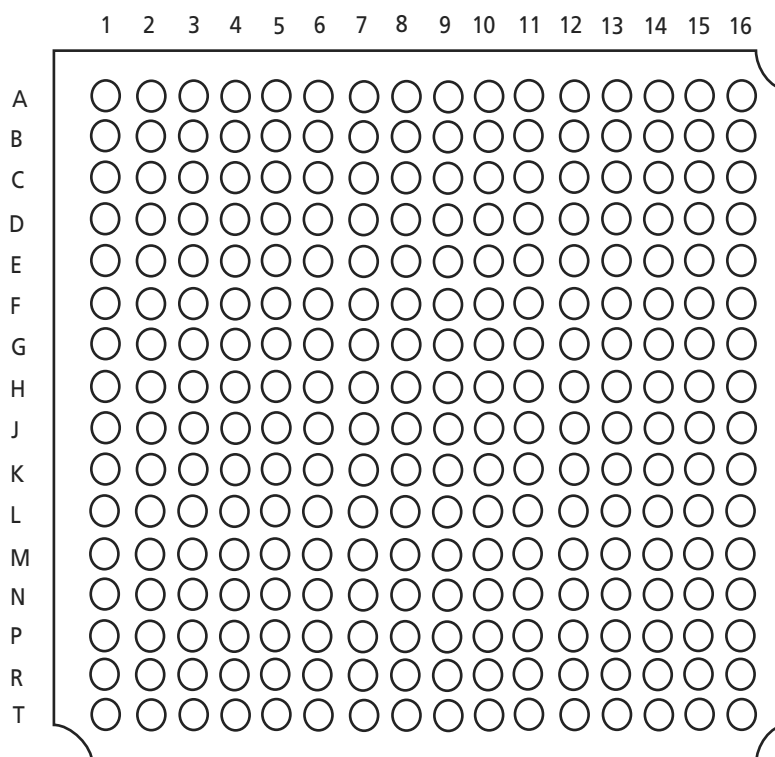


Figure 3-7 • 256-Pin FBGA (Top View)

### Note

For Package Manufacturing and Environmental information, visit Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

256-Pin FBGA			
Pin Number	A54SX16A Function	A54SX32A Function	A54SX72A Function
A1	GND	GND	GND
A2	TCK, I/O	TCK, I/O	TCK, I/O
A3	I/O	I/O	I/O
A4	I/O	I/O	I/O
A5	I/O	I/O	I/O
A6	I/O	I/O	I/O
A7	I/O	I/O	I/O
A8	I/O	I/O	I/O
A9	CLKB	CLKB	CLKB
A10	I/O	I/O	I/O
A11	I/O	I/O	I/O
A12	NC	I/O	I/O
A13	I/O	I/O	I/O
A14	I/O	I/O	I/O
A15	GND	GND	GND
A16	GND	GND	GND
B1	I/O	I/O	I/O
B2	GND	GND	GND
B3	I/O	I/O	I/O
B4	I/O	I/O	I/O
B5	I/O	I/O	I/O
B6	NC	I/O	I/O
B7	I/O	I/O	I/O
B8	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
B9	I/O	I/O	I/O
B10	I/O	I/O	I/O
B11	NC	I/O	I/O
B12	I/O	I/O	I/O
B13	I/O	I/O	I/O
B14	I/O	I/O	I/O
B15	GND	GND	GND
B16	I/O	I/O	I/O
C1	I/O	I/O	I/O
C2	TDI, I/O	TDI, I/O	TDI, I/O
C3	GND	GND	GND
C4	I/O	I/O	I/O
C5	NC	I/O	I/O

256-Pin FBGA			
Pin Number	A54SX16A Function	A54SX32A Function	A54SX72A Function
C6	I/O	I/O	I/O
C7	I/O	I/O	I/O
C8	I/O	I/O	I/O
C9	CLKA	CLKA	CLKA
C10	I/O	I/O	I/O
C11	I/O	I/O	I/O
C12	I/O	I/O	I/O
C13	I/O	I/O	I/O
C14	I/O	I/O	I/O
C15	I/O	I/O	I/O
C16	I/O	I/O	I/O
D1	I/O	I/O	I/O
D2	I/O	I/O	I/O
D3	I/O	I/O	I/O
D4	I/O	I/O	I/O
D5	I/O	I/O	I/O
D6	I/O	I/O	I/O
D7	I/O	I/O	I/O
D8	PRA, I/O	PRA, I/O	PRA, I/O
D9	I/O	I/O	QCLKD
D10	I/O	I/O	I/O
D11	NC	I/O	I/O
D12	I/O	I/O	I/O
D13	I/O	I/O	I/O
D14	I/O	I/O	I/O
D15	I/O	I/O	I/O
D16	I/O	I/O	I/O
E1	I/O	I/O	I/O
E2	I/O	I/O	I/O
E3	I/O	I/O	I/O
E4	I/O	I/O	I/O
E5	I/O	I/O	I/O
E6	I/O	I/O	I/O
E7	I/O	I/O	QCLKC
E8	I/O	I/O	I/O
E9	I/O	I/O	I/O
E10	I/O	I/O	I/O

256-Pin FBGA			
Pin Number	A545X16A Function	A545X32A Function	A545X72A Function
E11	I/O	I/O	I/O
E12	I/O	I/O	I/O
E13	NC	I/O	I/O
E14	I/O	I/O	I/O
E15	I/O	I/O	I/O
E16	I/O	I/O	I/O
F1	I/O	I/O	I/O
F2	I/O	I/O	I/O
F3	I/O	I/O	I/O
F4	TMS	TMS	TMS
F5	I/O	I/O	I/O
F6	I/O	I/O	I/O
F7	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
F8	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
F9	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
F10	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
F11	I/O	I/O	I/O
F12	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
F13	I/O	I/O	I/O
F14	I/O	I/O	I/O
F15	I/O	I/O	I/O
F16	I/O	I/O	I/O
G1	NC	I/O	I/O
G2	I/O	I/O	I/O
G3	NC	I/O	I/O
G4	I/O	I/O	I/O
G5	I/O	I/O	I/O
G6	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
G7	GND	GND	GND
G8	GND	GND	GND
G9	GND	GND	GND
G10	GND	GND	GND
G11	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
G12	I/O	I/O	I/O
G13	GND	GND	GND
G14	NC	I/O	I/O
G15	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>

256-Pin FBGA			
Pin Number	A545X16A Function	A545X32A Function	A545X72A Function
G16	I/O	I/O	I/O
H1	I/O	I/O	I/O
H2	I/O	I/O	I/O
H3	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
H4	TRST, I/O	TRST, I/O	TRST, I/O
H5	I/O	I/O	I/O
H6	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
H7	GND	GND	GND
H8	GND	GND	GND
H9	GND	GND	GND
H10	GND	GND	GND
H11	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
H12	I/O	I/O	I/O
H13	I/O	I/O	I/O
H14	I/O	I/O	I/O
H15	I/O	I/O	I/O
H16	NC	I/O	I/O
J1	NC	I/O	I/O
J2	NC	I/O	I/O
J3	NC	I/O	I/O
J4	I/O	I/O	I/O
J5	I/O	I/O	I/O
J6	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
J7	GND	GND	GND
J8	GND	GND	GND
J9	GND	GND	GND
J10	GND	GND	GND
J11	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
J12	I/O	I/O	I/O
J13	I/O	I/O	I/O
J14	I/O	I/O	I/O
J15	I/O	I/O	I/O
J16	I/O	I/O	I/O
K1	I/O	I/O	I/O
K2	I/O	I/O	I/O
K3	NC	I/O	I/O
K4	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>

484-Pin FBGA		
Pin Number	A54SX32A Function	A54SX72A Function
K10	GND	GND
K11	GND	GND
K12	GND	GND
K13	GND	GND
K14	GND	GND
K15	GND	GND
K16	GND	GND
K17	GND	GND
K22	I/O	I/O
K23	I/O	I/O
K24	NC *	NC
K25	NC *	I/O
K26	NC *	I/O
L1	NC *	I/O
L2	NC *	I/O
L3	I/O	I/O
L4	I/O	I/O
L5	I/O	I/O
L10	GND	GND
L11	GND	GND
L12	GND	GND
L13	GND	GND
L14	GND	GND
L15	GND	GND
L16	GND	GND
L17	GND	GND
L22	I/O	I/O
L23	I/O	I/O
L24	I/O	I/O
L25	I/O	I/O
L26	I/O	I/O
M1	NC *	NC
M2	I/O	I/O
M3	I/O	I/O
M4	I/O	I/O

484-Pin FBGA		
Pin Number	A54SX32A Function	A54SX72A Function
M5	I/O	I/O
M10	GND	GND
M11	GND	GND
M12	GND	GND
M13	GND	GND
M14	GND	GND
M15	GND	GND
M16	GND	GND
M17	GND	GND
M22	I/O	I/O
M23	I/O	I/O
M24	I/O	I/O
M25	NC *	I/O
M26	NC *	I/O
N1	I/O	I/O
N2	V <sub>CCI</sub>	V <sub>CCI</sub>
N3	I/O	I/O
N4	I/O	I/O
N5	I/O	I/O
N10	GND	GND
N11	GND	GND
N12	GND	GND
N13	GND	GND
N14	GND	GND
N15	GND	GND
N16	GND	GND
N17	GND	GND
N22	V <sub>CCA</sub>	V <sub>CCA</sub>
N23	I/O	I/O
N24	I/O	I/O
N25	I/O	I/O
N26	NC *	NC
P1	NC *	I/O
P2	NC *	I/O
P3	I/O	I/O

484-Pin FBGA		
Pin Number	A54SX32A Function	A54SX72A Function
P4	I/O	I/O
P5	V <sub>CCA</sub>	V <sub>CCA</sub>
P10	GND	GND
P11	GND	GND
P12	GND	GND
P13	GND	GND
P14	GND	GND
P15	GND	GND
P16	GND	GND
P17	GND	GND
P22	I/O	I/O
P23	I/O	I/O
P24	V <sub>CCI</sub>	V <sub>CCI</sub>
P25	I/O	I/O
P26	I/O	I/O
R1	NC *	I/O
R2	NC *	I/O
R3	I/O	I/O
R4	I/O	I/O
R5	TRST, I/O	TRST, I/O
R10	GND	GND
R11	GND	GND
R12	GND	GND
R13	GND	GND
R14	GND	GND
R15	GND	GND
R16	GND	GND
R17	GND	GND
R22	I/O	I/O
R23	I/O	I/O
R24	I/O	I/O
R25	NC *	I/O
R26	NC *	I/O
T1	NC *	I/O
T2	NC *	I/O

**Note:** \*These pins must be left floating on the A54SX32A device.

## Datasheet Categories

In order to provide the latest information to designers, some datasheets are published before data has been fully characterized. Datasheets are designated as "Product Brief," "Advanced," "Production," and "Datasheet Supplement." The definitions of these categories are as follows:

### Product Brief

The product brief is a summarized version of a datasheet (advanced or production) containing general product information. This brief gives an overview of specific device and family information.

### Advanced

This datasheet version contains initial estimated information based on simulation, other products, devices, or speed grades. This information can be used as estimates, but not for production.

### Unmarked (production)

This datasheet version contains information that is considered to be final.

### Datasheet Supplement

The datasheet supplement gives specific device information for a derivative family that differs from the general family datasheet. The supplement is to be used in conjunction with the datasheet to obtain more detailed information and for specifications that do not differ between the two families.

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